

N-Ch MOSFET

General Description

The WSF5N50A is silicon N-channel Enhanced VDMOSFETs, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy.

The transistor can be used in various power switching circuit for system miniaturization and higher efficiency.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

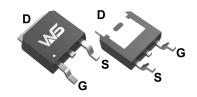
Product Summery

BV _{DSS}	R _{DSON}	I _D
500V	2400mΩ	4.8A

Applications

- Uninterruptible Power Supply(UPS)
- Power Factor Correction (PFC)

TO-252 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	500	V
V_{GS}	Gate-Source Voltage	±30	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	4.8	Α
I _{DM}	Pulsed Drain Current ²	14.4	Α
EAS	Single Pulse Avalanche Energy	57	mJ
I _{AR}	Avalanche Current ²	2.4	А
EAR	Repetitive Avalanche Energy	6.4	mJ
P _D @T _C =25°C	Total Power Dissipation	32.9	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-ambient ¹		62.5	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		6.25	°C/W

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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_D =250uA	500			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =1mA		0.25		V/℃	
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =3.5A		2400	3000	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	2.0	3.0	4.0	٧	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID -250UA		-4.64		mV/℃	
I _{DSS}	Drain-Source Leakage Current	V_{DS} =400V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C			1	uA	
יטאַ	Drain-Godice Leakage Guitent	V_{DS} =400V , V_{GS} =0V , T_J =150 $^{\circ}$ C			200	u.A	
I_{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm30V$, V_{DS} = $0V$			±100	nA	
gfs	orward Transconductance	V _{DS} =30V , I _D =2.5A		5.2		S	
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		4.2		Ω	
Qg	Total Gate Charge (10V)			8			
Q_gs	Gate-Source Charge	V_{DS} =400V , V_{GS} =10V , I_{D} =2A		1.2		nC	
Q_gd	Gate-Drain Charge			5			
$T_{d(on)}$	Turn-On Delay Time			7.8			
Tr	Rise Time	V -250V D -250 L -24		33		20	
$T_{d(off)}$	Turn-Off Delay Time	V_{DD} =250V , R_G =25 Ω , I_D =3A.		23		ns	
T _f	Fall Time			59			
C _{iss}	Input Capacitance			310			
C _{oss}	Output Capacitance	V _{DS} =25V , V _{GS} =0V , f=1MHz		39		pF	
C _{rss}	Reverse Transfer Capacitance			6			

Diode Characteristics

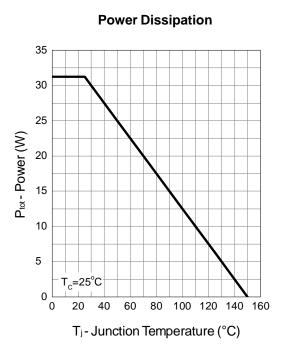
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			3.0	Α
I _{SM}	Pulsed Source Current ^{2,5}	V _G -V _D -UV , Force Current			12	Α
V_{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_{S} =3A , T_{J} =25 $^{\circ}$ C			1.4	V
t _{rr}	Reverse Recovery Time	ls=3A , dl/dt=100A/μs , T _J =25℃		80		nS
Q _{rr}	Reverse Recovery Charge	115-3A, αι/αι-100A/μ5, 1J-23 C		1.8		uC

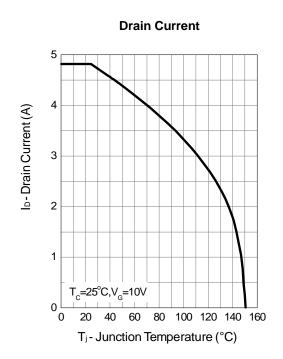
Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 4. The Min. value is 100% EAS tested guarantee.
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

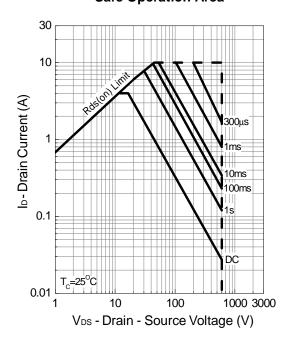


Typical Characteristics

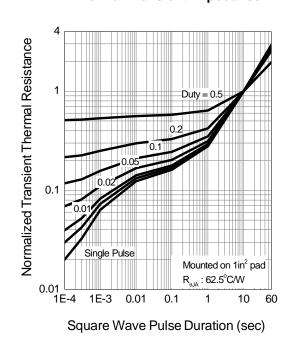




Safe Operation Area

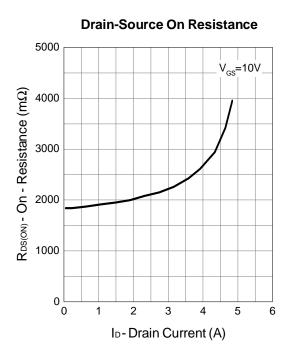


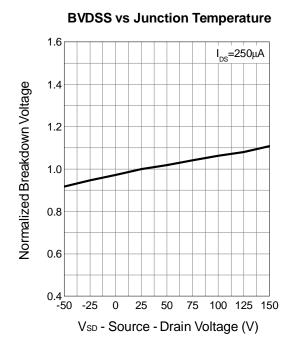
Thermal Transient Impedance

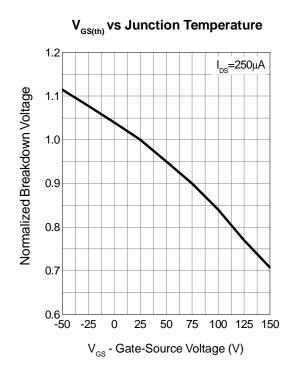


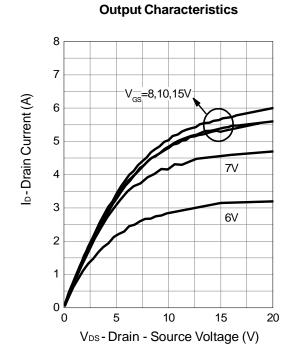


Typical Characteristics (Cont.)



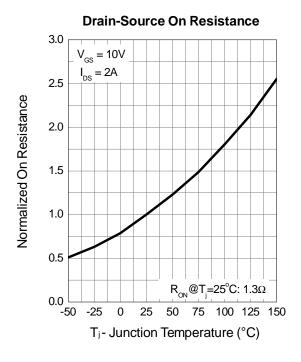


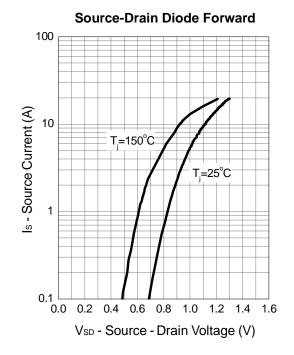




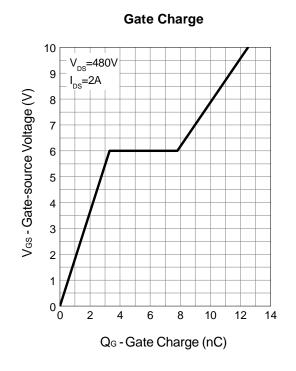


Typical Characteristics (Cont.)



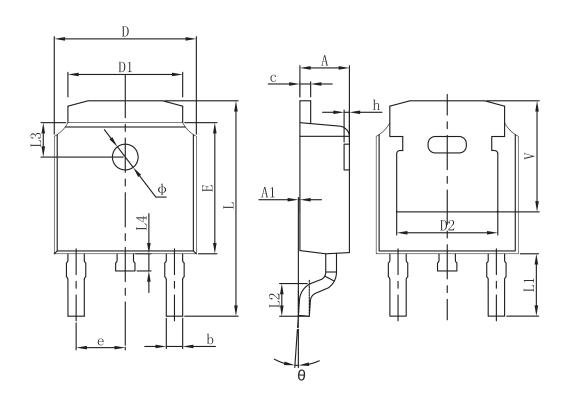


Capacitance 10000 Frequency=1MHz 1000 C - Capacitance (pF) Ciss 100 Coss 10 5 10 15 20 25 30 V_{DS} - Drain - Source Voltage (V)





Packaging information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.635	0.770	0.025	0.030	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830	REF.	0.190 REF.		
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.712	10.312	0.382	0.406	
L1	2.900 REF.		0.114 REF.		
L2	1.400	1.700	0.055	0.067	
L3	1.600	REF.	0.063 REF.		
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.250	REF.	0.207 REF.		



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